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## BIB DATA SHEET

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## APPLICANTS

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## \*\* CONTINUING DATA \*\*\*\*\*

## \*\* FOREIGN APPLICATIONS \*\*\*\*\*

JAPAN 2002-239194 08/20/2002

## \*\* IF REQUIRED, FOREIGN FILING LICENSE GRANTED \*\*

11/13/2003

Foreign Priority claimed <input checked="" type="checkbox"/> Yes <input type="checkbox"/> No	<input type="checkbox"/> Met after Allowance	STATE OR COUNTRY JAPAN	SHEETS DRAWINGS 44	TOTAL CLAIMS 12	INDEPENDENT CLAIMS 8
35 USC 119(a-d) conditions met <input checked="" type="checkbox"/> Yes <input type="checkbox"/> No	Initials				
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## TITLE

Extracting method of pattern contour, image processing method, searching method of pattern edge,  
 scanning method of probe, manufacturing method of semiconductor device, pattern inspection apparatus,  
 and program

FILING FEE RECEIVED 2632	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit
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